



# Magnetic Materials: External solutions to reduce EMI without redesigning





#### CATEDRA EMC WE-UV Würth Elektronik – University of Valencia

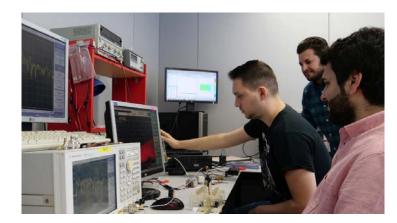


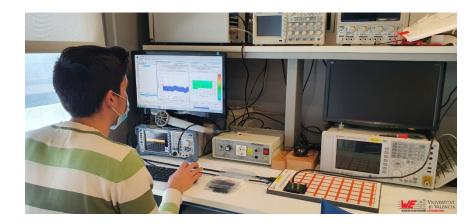
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# **Catedra EMC WE-UV**



- Catedra EMC is a wide and long-term academic collaboration between the company Würth Elektronik and the University of Valencia, which reaches several areas of knowledge related to EMC.
- It extends its activities to all the areas of the university activity:
  - Teaching and Dissemination of science, technology and culture
  - Research and Innovation
  - Training and talent attraction







# Outline

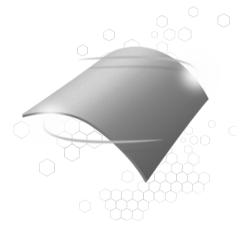




- **1.** Electromagnetic Shielding
  - 1.1. Introduction to EM Shielding
  - 1.2. Properties of magnetic materials
  - **1.3**. EM Shielding techniques (video-demo 1)
  - 1.4. Shielding RFID/NFC systems (video-demo 2)

#### 2. Cable Ferrites

- 2.1. Introduction and applications
- 2.2. Properties of cable ferrites
- 2.3. Selecting the best cable ferrite
- 2.4. Insertion loss parameter
- 2.5. Live-demo





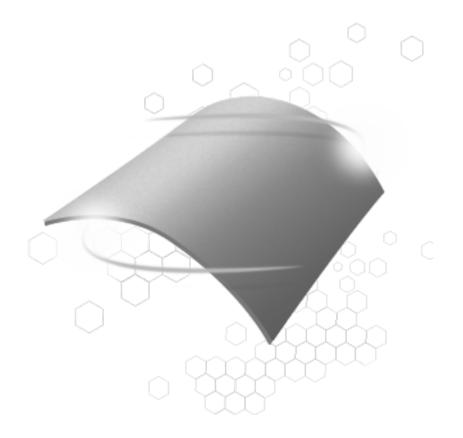
# Outline





#### 1. Electromagnetic Shielding

- **1.1.** Introduction to EM Shielding
- **1.2.** Properties of magnetic materials
- **1.3**. EM Shielding techniques (video-demo 1)
- 1.4. Shielding RFID/NFC systems (video-demo 2)





- The trend towards developing smaller electronic devices with more features and better is increasing the problems caused by Electromagnetic Interferences.
- These design requirements may result in the next features:
  - higher component integration
  - PCB size and thickness reduction
  - the miniaturization and weight reduction of the device housing
  - higher switching frequencies in power converters and communication data rates in digital circuits
  - possibility of devices interconnection (wired or wireless)
- Consequently, EMC engineering should be handled with the system approach, considering EMC throughout the design
  process to prevent possible EMI problems that could degrade device performance.
- Adopting specific solutions as early as possible in the design stage to meet the EMC requirements is essential to reduce penalties in costs, time-to-market, and performance.



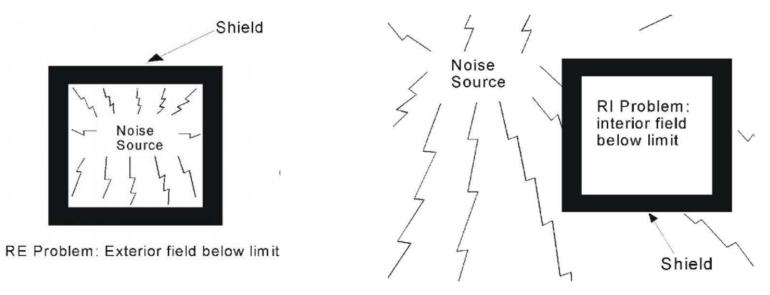
- However, it is not always possible to predict EMI problems during the design stage because it is difficult to consider the real behavior of the final system.
- When a designer faces an EMI problem, the following elements should be identified:



- It is recommended to suppress EMI at its source whenever possible, rather than increasing immunity through the victim's circuit protections.
- A single EMI source could find multiples propagation paths and affecting to several victims.



- An interesting technique used to reduce EMI problems is the use of EM shielding products.
- It can be used to contain the electromagnetic fields generated by an EMI source (reducing its emission) or protecting a sensitive device against the field present in the work environment (increasing its immunity), .



For external noise source (immunity):



- An innovative technique to solve complex EMI problems is the use of shielding flexible sheets based on magnetic materials.
- These shielding products can be obtained by these two solutions:

Flexible Absorber Sheets (FAS)



FAS solution consists of a composite material with magnetic particles embedded in a polymer.

Flexible Sintered Ferrite Sheets (FSFS)



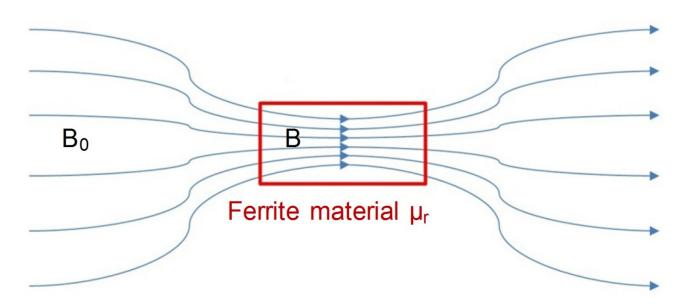
FSFS is composed of precracked thin ferrite plates placed between a layer of adhesive tape and a PET cover layer.

## **1.2.** Properties of magnetic materials



- These magnetic materials have a property which allows them to influence the magnetic field in its environment: RELATIVE PERMEABILITY (μ<sub>r</sub>)
- These materials have a greater permeability to magnetic fields than the air around them, which thus concentrates the magnetic field lines.

 $\mu_r = B/B_0 = \mu/\mu_0$ 

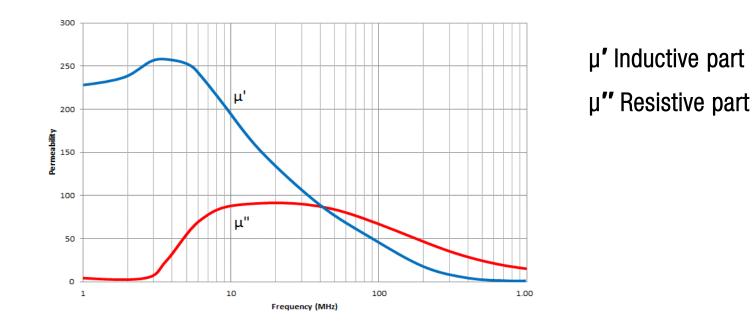


## **1.2.** Properties of magnetic materials

- WÜRTH ELEKTRONIK CÁTEDRA EMC
- By separating μ<sub>r</sub> into its complex form, the real component provides the reflection part and the imaginary component the absorption part:

 $\mu_r = \mu' - j\mu''$ 

 Depending on the application it is possible to choose materials that absorb emissions in a certain frequency range or reflect to concentrate the magnetic flux.



## **1.2.** Properties of magnetic materials

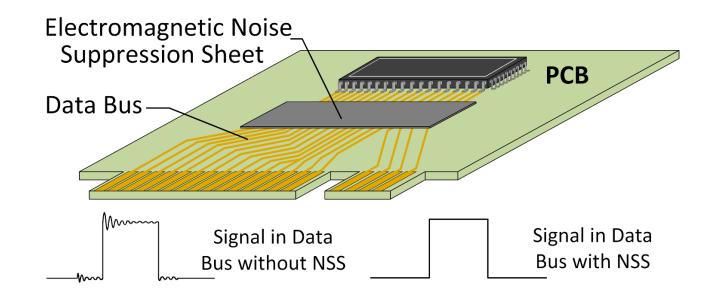


- Besides the permeability, other factors that defines the performance of these sheets are:
  - Sheet thickness.
  - Size and geometry of the sheet.
  - Kind of adhesive.
  - Distance between the sheet and the EMI source.
- In order to analyze the response of these shielding solutions in different applications, it is better to obtain a real approach through some experimental characterization methods.
- Thereby, it is possible to analyze the shielding performance by comparing several sheets and thicknesses that provide different performances.

## **1.3.** EM Shielding techniques: Transmission Lines



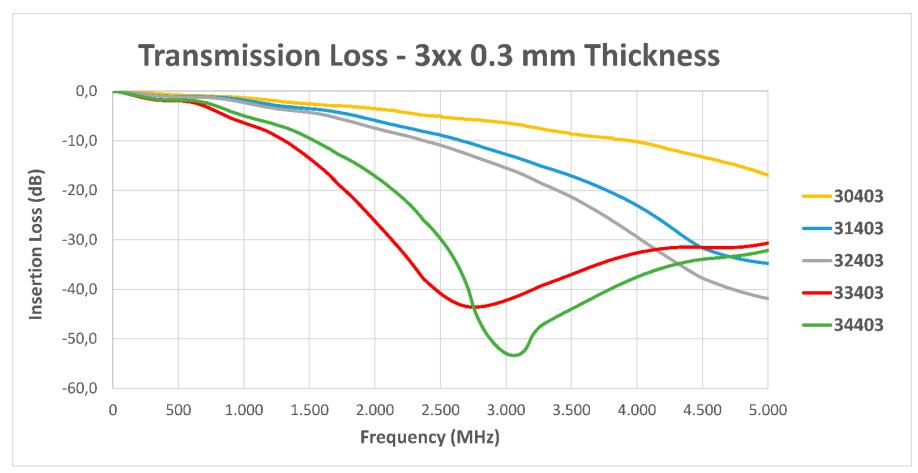
- This kind of problem can appear in data buses where there are some digital signals switching at some MHz.
- By placing the shielding on the data bus, it acts as a low-pass filter attenuating high-frequency interferences.
- It is possible to use a characterization experimental setup that provides an approach of the shielding effectiveness provided by shielding sheets to reduce transmission line problems.



## **1.3. EM Shielding techniques: Transmission Lines**



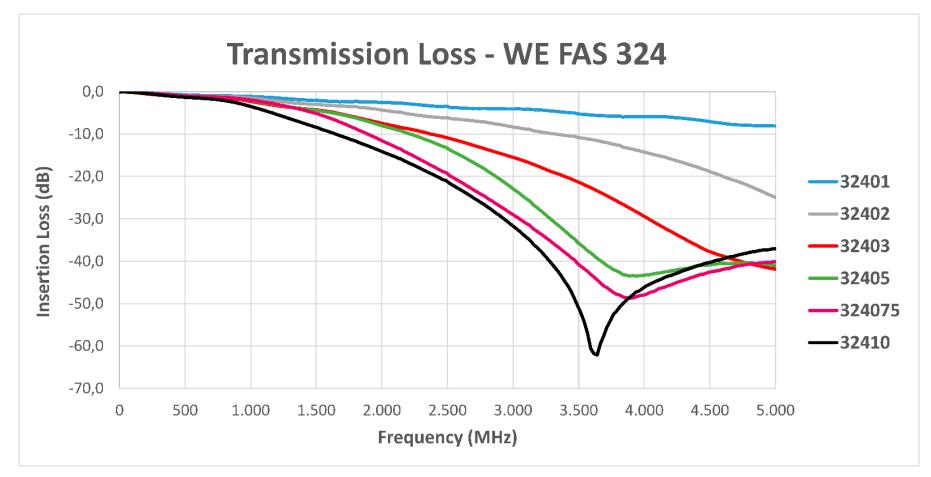
 Transmission Loss parameter measured by selecting some FAS based on different material composition, but the same sheet thickness: 0.3 mm.



#### **1.3.** EM Shielding techniques: Transmission Lines



 Transmission Loss parameter measured by selecting the same FAS material composition, but with different sheet thicknesses: from 0.1 mm to 1.0 mm.

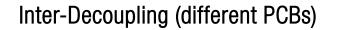


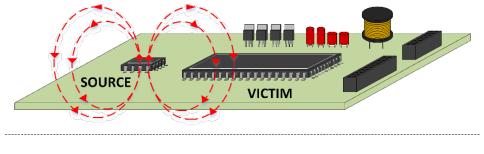
#### **1.3.** EM Shielding techniques: Magnetic Decoupling

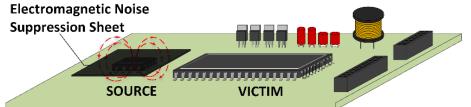


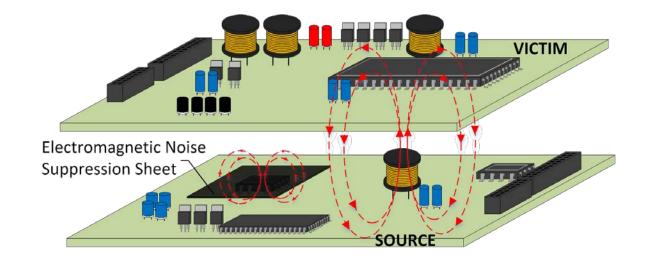
- Magnetic decoupling is a common problem in electronic systems which hold some PCBs or devices with space limits that contain very close electronic circuits.
- It is possible to reduce the interferences by placing the shielding sheet on the EMI source or the victim, to protect it against interferences.

Intra-Decoupling (same PCB)





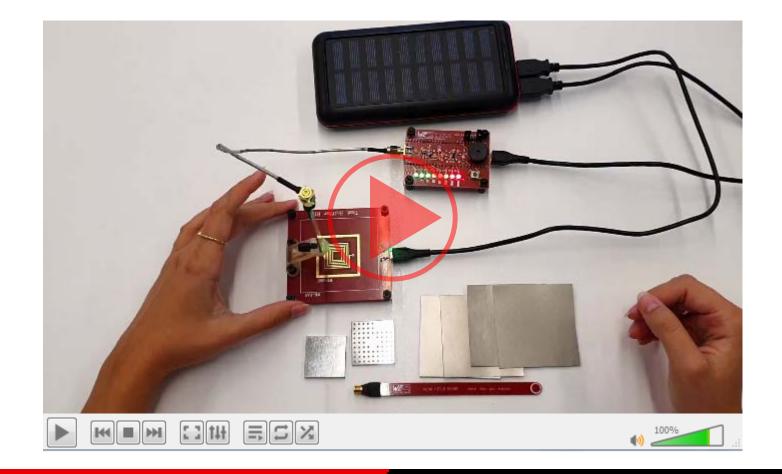




#### **1.3. EM Shielding techniques: Magnetic Decoupling**

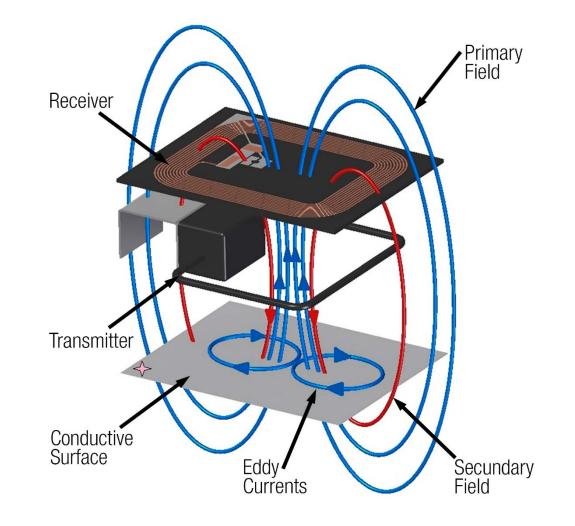


 Next video shows a demonstration about the effectiveness of Flexible Absorber Sheets to reduce magnetic decoupling problems. A high-permeability FAS (3441) is evaluated by using different sheet thicknesses.



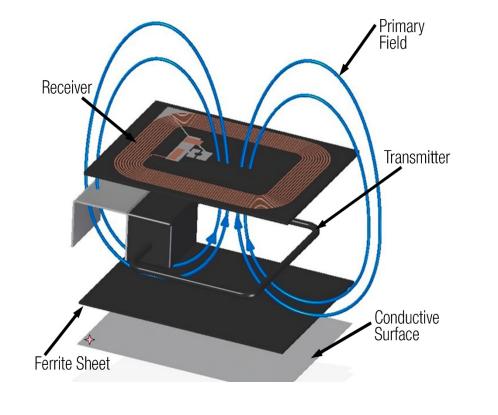


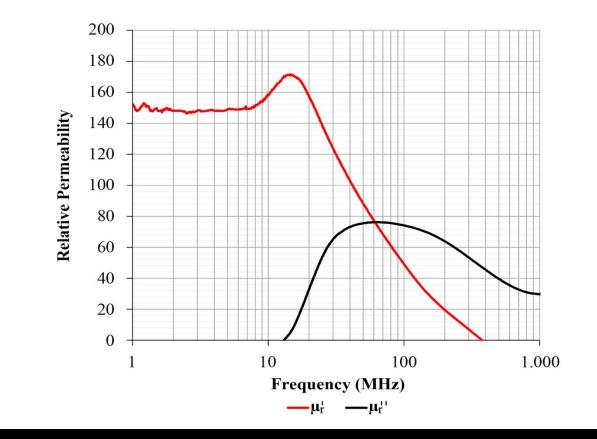
- The reduction of embedded portable devices involves a magnetic field interference problem when it integrates Near Field Communication due to the presence of conductive surfaces such as ground planes, batteries or metallic enclosures.
- When a conductive plane is located under the communication area, the magnetic field lines produce eddy currents, which, generates an opposite stray *H* to the intended primary *H*.
- Therefore, the performance of the magnetic coupling is reduced, resulting in an efficiency reduction of the communication distance.





- Magnetic shielding sheets represent an interesting solution to prevent EMI problems related to NFC or RFID thanks to their ability to control the magnetic flux.
- It is important to select a shielding sheet that provides high μ' and low μ'' at the communication frequency (13.56 MHz).

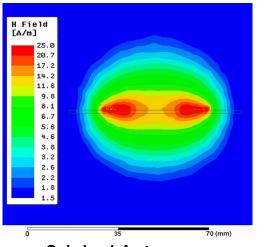




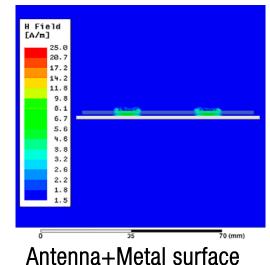


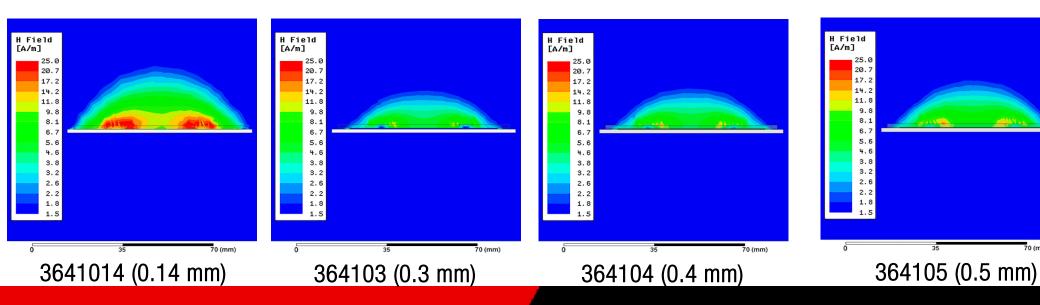
70 (mm)

- The simulation of an RFID antenna shows the effect of introducing a conductive surface under the transmitter antenna and the performance of the FSFS shielding to recover the original field of the antenna.
- The FSFS analyzed is the 3641 with the thicknesses 0.14 mm, 0.3 mm, 0.4 mm, and 0.5 mm.



**Original Antenna** 







Next video shows a demonstration about the effectiveness of Flexible Sintered Ferrite Sheets to shield a RFID/NFC communication system against the proximity of conductive surfaces. A high-permeability FSFS (3641) is evaluated.



# Outline





#### **2.** Cable Ferrites

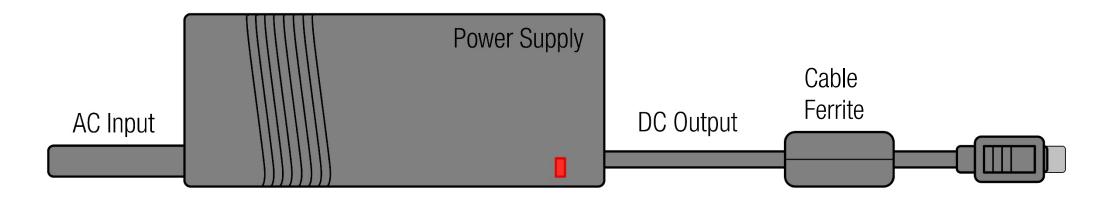
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## **2.1.** Introduction and Applications of Cable Ferrites



- Unexpected EMI sources in cables can appear in our system when it is connected to another device.
- One of the most used techniques for reducing interferences in cables is applying an EMI suppressor such as a cable ferrite to them.
- This EMI suppressor provides selective attenuation of undesired interference emissions that the designer may wish to suppress and it does not affect the intended signal.
- Thereby, this component is widely used to filter:
  - EMI in power cables to reduce high-frequency oscillations generated by switching transients or parasitic resonances within a circuit.
  - EMI in peripheral cables of electronic devices such as multiconductor USB or video cables.



## **2.1.** Introduction and Applications of Cable Ferrites

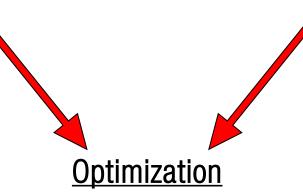


#### <u>Advantage</u>

It does <u>not involve redesign</u> the electronics and, generally, the mechanical redesign. This is an important advantage because determining in the testing stage which is the EMI source, may not be simple.

#### **Drawbacks**

The addition of an extra component results in increasing the size and weight of the product besides the <u>cost</u> of this.



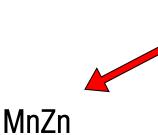
Determine which material best solve the problem of our design and select the cable ferrite with the lowest weight, dimensions and cost.



#### **Conventional Materials: MnZn and NiZn**

Ceramic materials, heat resistance, stability over a wide temperature range,

hardness, high resistance to pressure, possibility of manufacturing components with many different shapes and dimensions

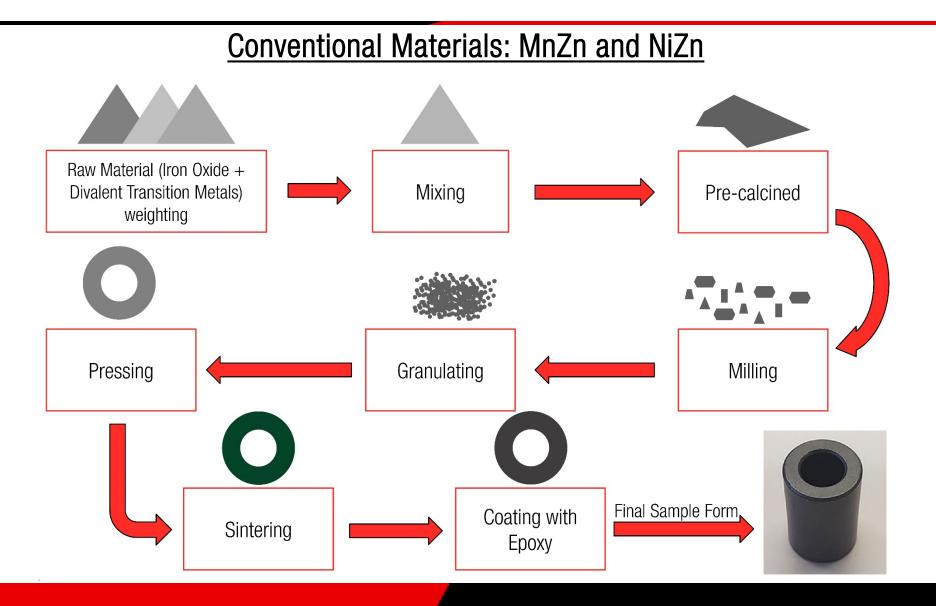


- Initial Permeability: 1000 20,000
  - Low resistivity: 0.1 100 Ω⋅m
- Frequency range: from hundreds of kHz to some MHz



- Initial Permeability : 100 2000
- High resistivity :  $10^4$ - $10^6 \Omega \cdot m$
- Frequency range: from tens of MHz up to several hundreds of MHz

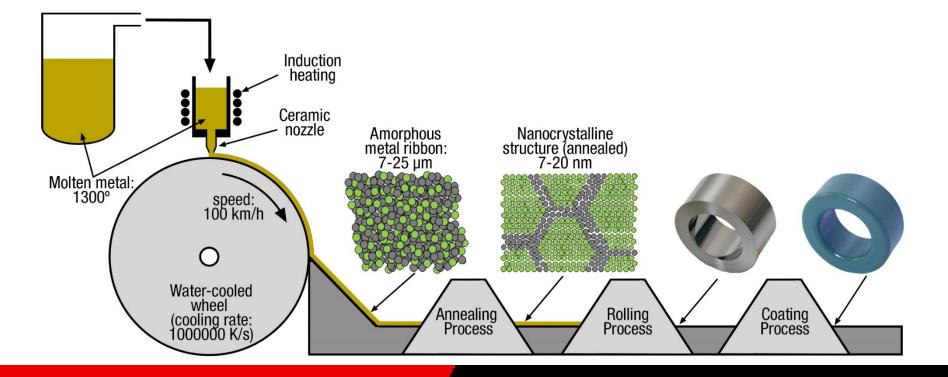






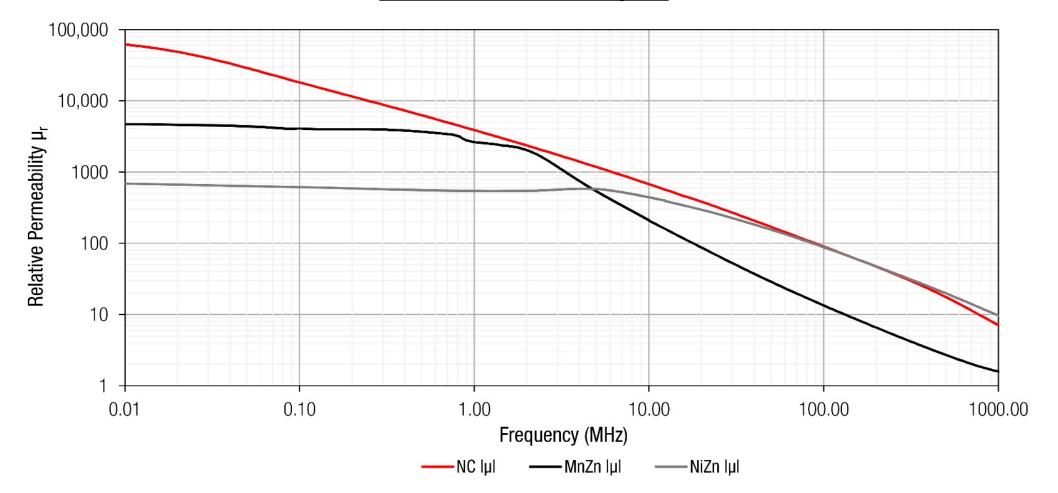
#### Materials with Nanocrystalline structure

- Very high initial permeability (15,000 to 150,000)
- Low resistivity since it is defined as a metal (10<sup>-6</sup>  $\Omega$ ·m)
  - Complicated manufacturing non-toroidal samples
    - Protected with a case or epoxy coating



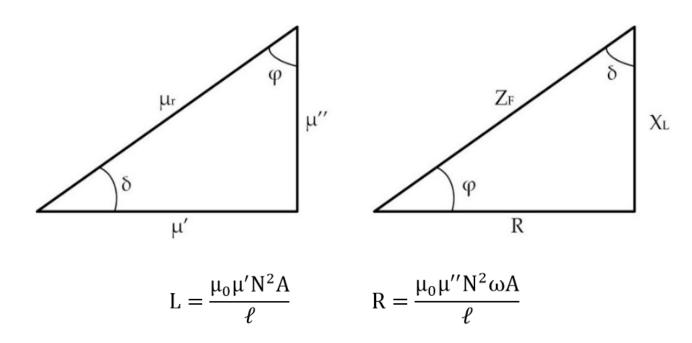


#### **Relative Permeability** IµI

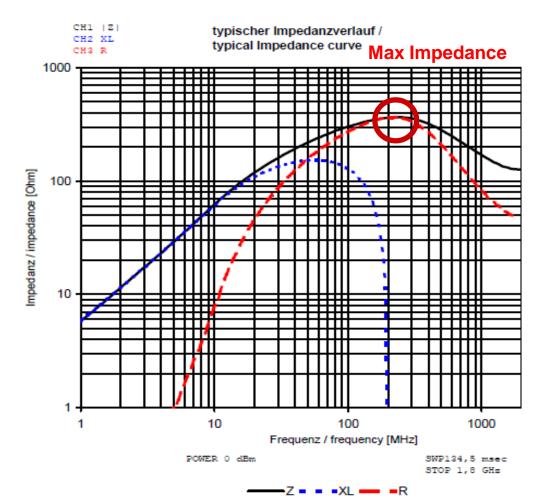








*N* is the number of turns, *A* ferrite transversal section and *I* is the magnetic path length

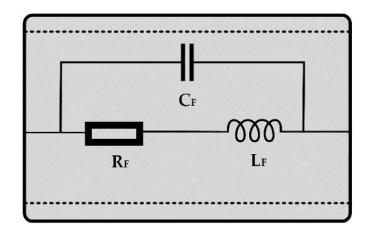


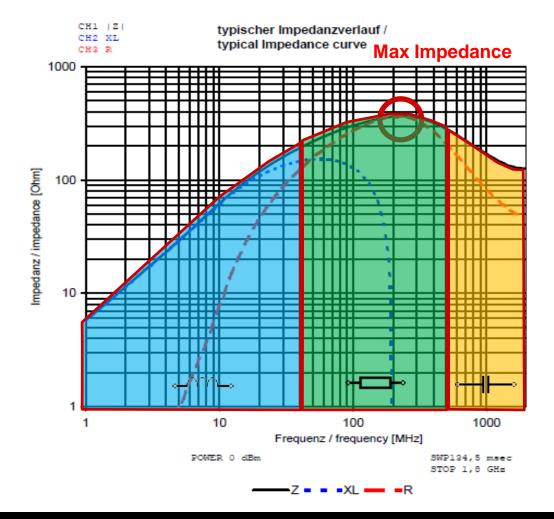
**Impedance vs Frequency** 



Cable Ferrite equivalent model

$$|\mathbf{Z}_{\mathrm{F}}| = \sqrt{\mathbf{R}^2 + (\mathbf{X}_{\mathrm{L}})^2}$$

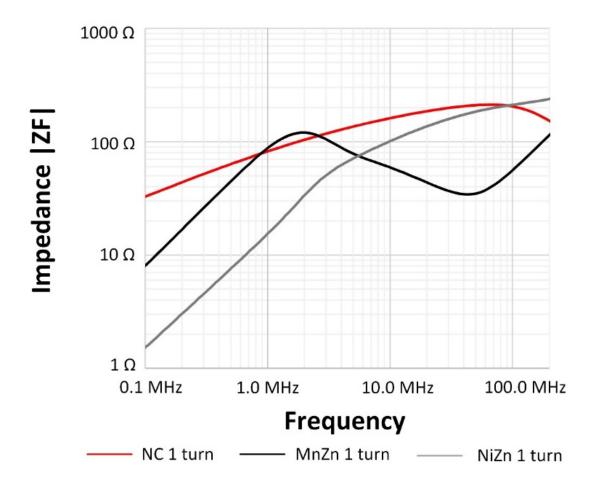




**Impedance vs Frequency** 



• It is essential to know at which frequencies are located the EMI problems to select the most suitable cable ferrite material.





It is possible to increase the impedance that a cable ferrite introduce into a cable by placing two of them or by increasing the number of turns but, which solution is more interesting?

Increasing the number of turns N does not increase in costs and allows to obtain an impedance proportional to the square of N. However, the L and C are increased and the SFR decreases in frequency.

$$|\underline{Z}| = N^2 * \mu_0 * \sqrt{(\mu_r'')^2 + (\mu_r')^2} * f * l * \ln(\mathbf{A})$$

Increasing the number of ferrites N increases costs and makes it possible to obtain an impedance proportional to twice that of N. It increases L, but also R.

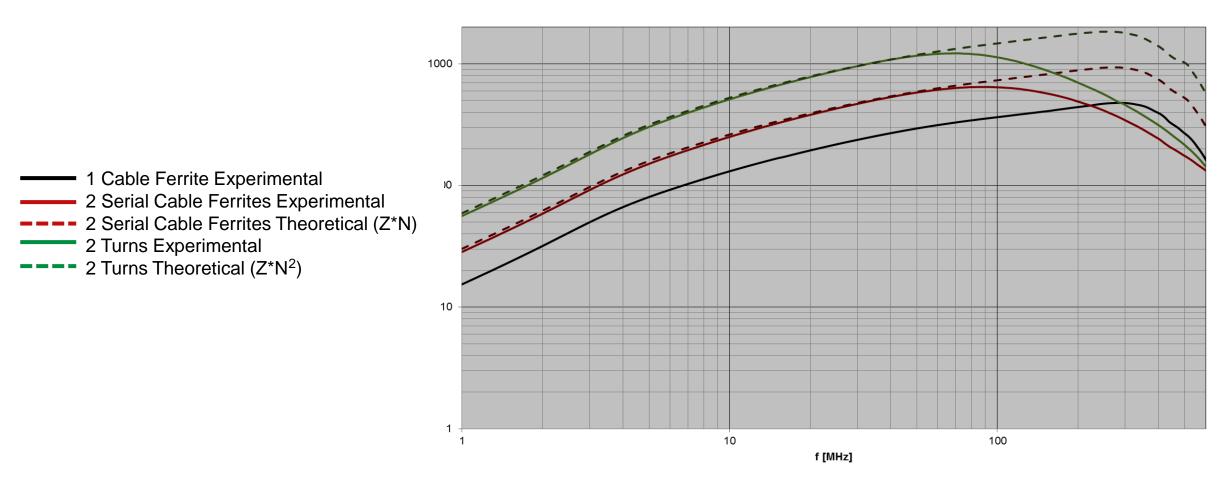
$$|\underline{Z}| = N * \mu_0 * \sqrt{(\mu_r'')^2 + (\mu_r')^2} * f * l * \ln(A)$$





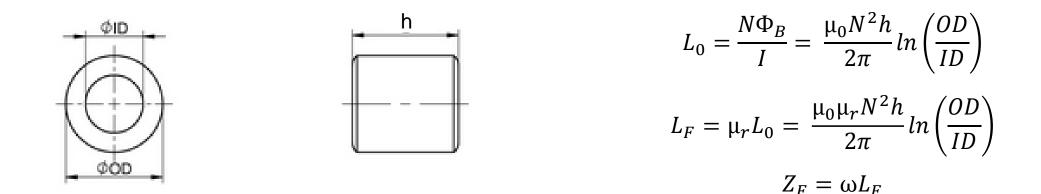


It is possible to increase the impedance that a cable ferrite introduce into a cable by placing two of them or by increasing the number of turns but, which solution is more interesting?





- Other important parameter to be considered in the selection of the cable ferrite is the dimensions.
- The optimized dimensions of the cable ferrite can be determined by considering the impedance needed to attenuate the interferences in the cable to be protected.
- This formula makes it possible to calculate the impedance provided by a certain cable ferrite by knowing its dimensions and relative permeability:





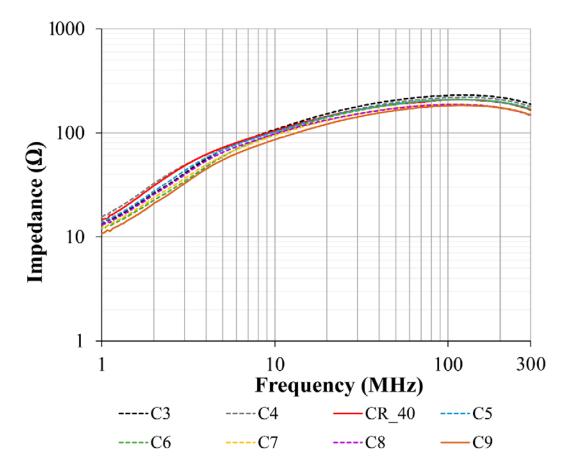
- Considering these parameters, to maximize the impedance provided by the cable ferrite it is interesting select the maximum OD/ID ratio and height while the ID is as tight as possible to the cable diameter.
- Nevertheless, the increase of the dimensions is usually proportional to its weight, volume and cost. Hence, a balance between these three features and performance should be carried out.
- Thereby, it should be taken into account that:
  - the impedance is proportional to the natural logarithm of the ratio of the outer to the inner diameter and directly proportional to the height.
  - even though *h* is directly proportional to the impedance, the natural logarithm provides an attenuation factor when the ID is lower than 2.7 times the *OD*, so that it is crucial not selecting thin cores since
    - for instance, *OD/ID* ratios of 2.0 or 1.5 reduce the performance of the sleeve core about 30% and 60%, respectively.



• Therefore, not always the cable ferrite with higher volume provides the best performance.



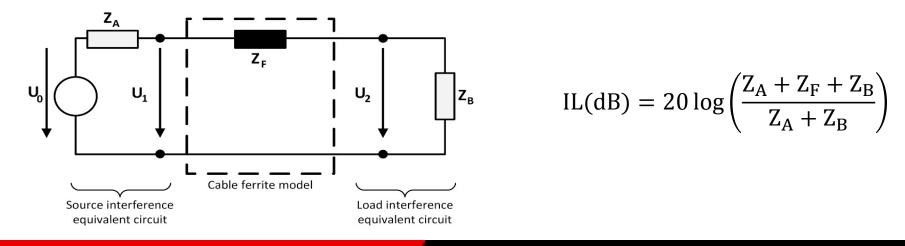
| ID    | h<br>(mm) | OD/ID<br>(mm) | Vol.<br>(cm³) | Lo<br>(nH) | Z <sub>F</sub><br>@100<br>MHz<br>(Ω) | L₀/h<br>(nH/<br>mm) | Z <sub>F</sub> /h<br>(Ω/mm) |
|-------|-----------|---------------|---------------|------------|--------------------------------------|---------------------|-----------------------------|
| C3    | 28.5      | 2.22          | 3.50          | 4.55       | 228.0                                | 0.16                | 8.00                        |
| C4    | 28.5      | 2.12          | 4.18          | 4.29       | 217.4                                | 0.15                | 7.63                        |
| CR_40 | 40.0      | 1.65          | 7.19          | 4.02       | 208.0                                | 0.10                | 5.20                        |
| C5    | 28.5      | 2.00          | 4.30          | 3.95       | 207.8                                | 0.14                | 7.29                        |
| C6    | 28.5      | 2.00          | 11.35         | 3.95       | 207.4                                | 0.14                | 7.28                        |
| C7    | 15.0      | 3.33          | 1.54          | 3.61       | 186.9                                | 0.24                | 12.46                       |
| C8    | 28.5      | 1.84          | 4.83          | 3.48       | 187.0                                | 0.12                | 6.56                        |
| C9    | 25.0      | 1.97          | 2.94          | 3.40       | 181.9                                | 0.14                | 7.28                        |



#### **2.4.** Insertion Loss parameter



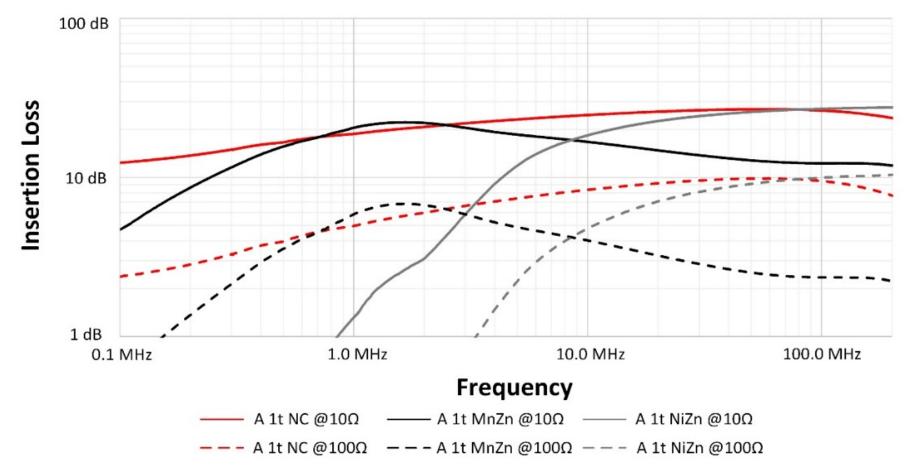
- Sometimes it is difficult to determine the impedance of the system with EMI problems accurately; however, depending on the signals that flow through the cable, it is possible to estimate this value:
  - Ground surfaces usually present impedances from 1 to 2  $\Omega$ .
  - Supply voltage lines have impedances from 10 to 20  $\Omega$ .
  - Video, clock, and data lines from 50  $\Omega$  to 90  $\Omega$ .
  - Long data lines from 90  $\Omega$  to 150  $\Omega$  and higher.
- The theoretical insertion loss or attenuation of a specific cable ferrite can be determined from its impedance response by considering the equivalent circuit approach.



#### **2.4.** Insertion Loss parameter



• If  $ZA = ZB = 10 \Omega$  (solid lines) and  $ZA = ZB = 100 \Omega$  (dashed lines) cases are considered, the following Insertion Loss is obtained for N=1:







# Magnetic Materials: External solutions to reduce EMI without redesigning

# **THANKS FOR YOUR ATTENTION!**

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